

ASK A PSYCHOMETRICIAN: PSYCHOMETRIC ANALYSES & OPERATIONS

Lisa S. O'Leary, Ph.D. September 3, 2014

Agenda

- Discussion of methods and statistical approaches for:
 - Beta Testing Prior to Live Form Administration
 - Item-Level and Form-Level Analyses
 - Forms Assembly & Equating



Establish Baseline Parameters Through Effective & Advantageous

BETA TESTING



Stage in Process



Purpose

- Gather evidence of appropriateness of the items to the content specifications and intended use of test scores
 - Can collect data during a beta exam or concurrent with operational administration

Beta Test

Seed Pilot Items

Purpose of the test program changes

Significant content domain changes

Expectations or definition of MQC changes

All new/large set of items are being developed

Purpose of the test program remains the same

Minimal content domain changes

Similar expectations or definition of the MQC

Small set of new items being developed



Exam Release Cycle

- Alpha test complex item types (optional)
- Administer beta forms to gather initial itemlevel statistics and exam-level data
- Analyze data

Beta Item
Selection

Forms Assembly

- Review exam and formlevel statistics
- Delete items that are not performing well
- Set aside items viable after revision with SMEs
- Keep items that are performing well as viable for new forms
- Conduct standard setting

- Administer operational forms
- Provide pass/fail decisions to beta candidates
- Seed unscored items to pilot and obtain statistics
- After reaching a certain administration period or candidate volume, send data to Alpine for analysis

Health Check



Beta Testing

Decision on whether or not to beta test is based on a set of competing factors

Pros

Cons

Equate operational forms based on empirical item statistics

Consistent pass/fail decisions for all candidates

Follow approved exam development process

Collect item-level information, including difficulty, reliability, time

Lack of immediate scoring for candidates

Extension of exam development timeline

Potential exposure of beta items



Beta Testing

Need to determine the appropriate number of beta forms based on exam purpose and design

Goals

Use as few beta forms as possible

Administer as many items as reasonable (1.5 x live forms)

Beta sample should be sufficiently large and representative of candidate pool

Allow ample time for beta candidates to complete the exam, including comments

Proportionately meet the blueprint

Trade-Offs

Need enough beta forms to collect data on sufficient number of items to build live forms

Administration of entire item pool risks item exposure

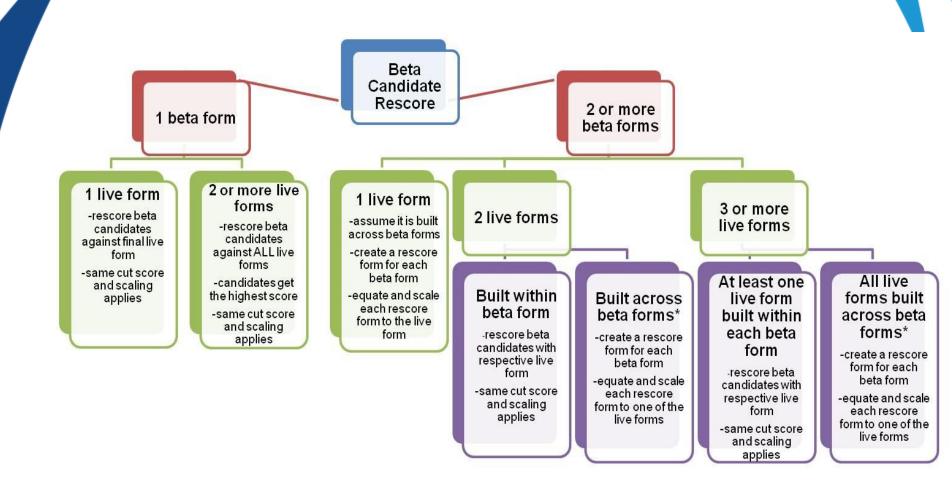
Beta candidates may lack motivation as a result of discounts or vouchers

Do not want time burden of beta exam to impact item statistics

Need to balance on all meaningful factors, including content and item type



Beta Rescore Considerations





Establish Item & Form Performance Through

ITEM & FORM ANALYSIS & STATISTICS



Stage in Process



Item- & Form-Level Analyses

- Evaluate statistical data regarding form- and itemlevel performance during operational administration
- Continually provide evidence of the following:
 - Adherence to the defined purpose of the exam
 - Quality of psychometric and statistical attributes
 - Appropriateness of standard setting results
 - Exposure and security review
 - Evaluation of fairness
 - Alignment with policy and administrative goals
- Inform future decisions regarding exam, forms, and items

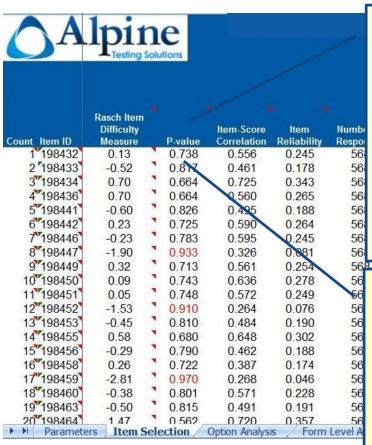


Item- & Form-Level Analyses

- Provide evidence of the health of an exam and its items
 - Use: Track exam volumes and pass rates over time
 - Performance: Ensure forms and items are functioning as intended in operational environment
 - Exposure: Track both item- and form-level exposure to address security concerns
- Provide support that the interpretation of exam scores remains appropriate over time



Item-Level Statistics: Item Difficulty



P-Value

- Item difficulty for dichotomous items (0,1) in CTT
- Proportion of candidates who answered the item correctly
- Ranges from 0 to 1, or 0% to 100%
- High values indicate easier items; low values indicate hard items
- Lower values indicate easier items; higher values indicate more difficult items

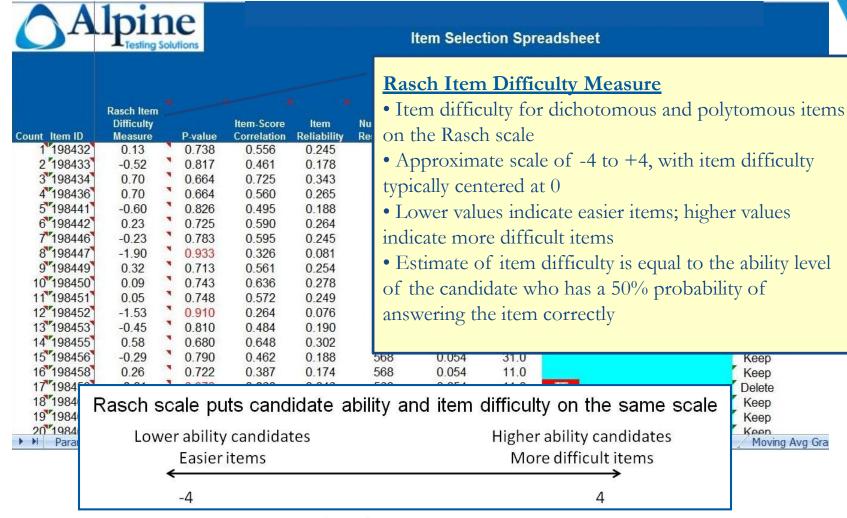
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Average Item Score

- Item difficulty for polytomous items (0 through maximum points value) in CTT
- Average number of score points earned by candidates
- Ranges from 0 to maximum number of points
- Interpret on the scale of the maximum number of points

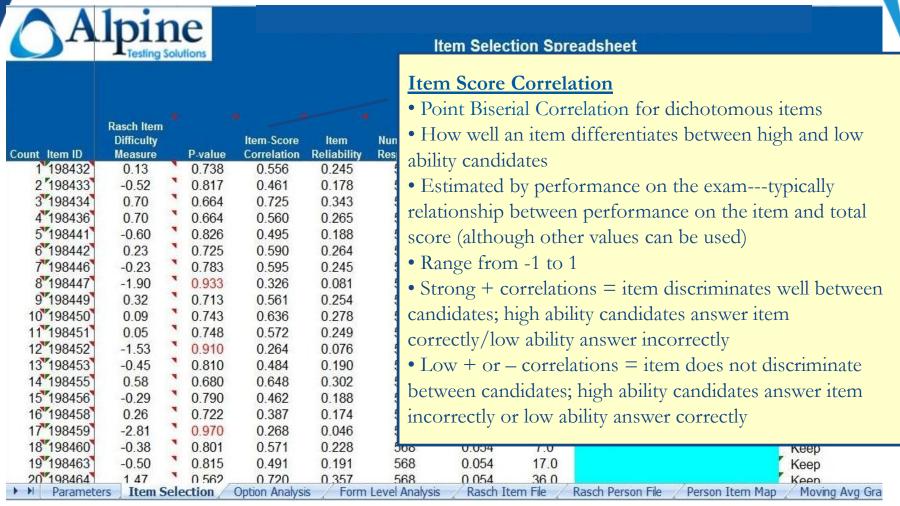


Item-Level Statistics: Item Difficulty





Item-Level Statistics: Correlation



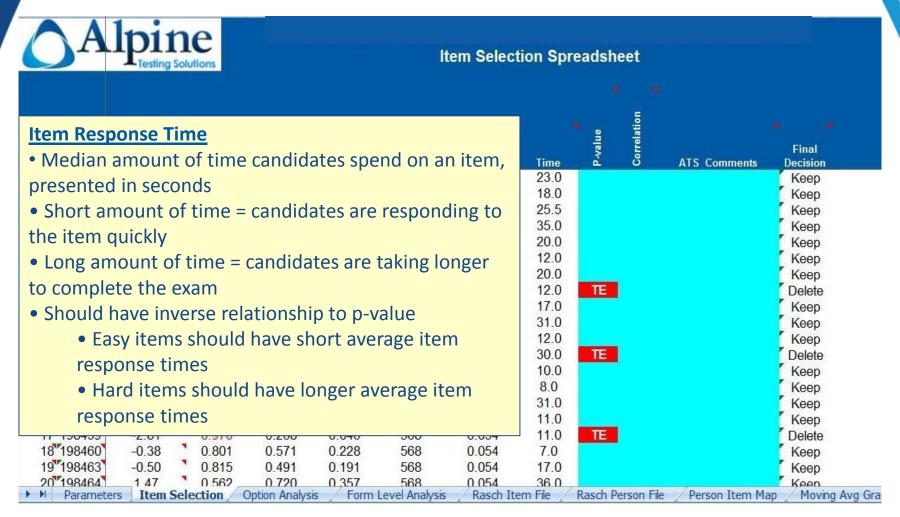


Item-Level Statistics: Reliability

OA	lpit Testing S	1	e				Item Reliability
							Measure of internal consistency
							Degree to which an item is contributing to and
	Rasch Item						measuring content in the same way as the test overall
Count Item ID	Difficulty Measure		P-value	Item-Score Correlation	Item Reliability	Numbe Respoi	• Range from -1 to 1
1 198432	0.13	1	0.738	0.556	0.245	568	• High + values = item contributing to the overall
2 198433	-0.52	4	0.817	0.461	0.178	568	
3 198434	0.70	7	0.664	0.725	0.343	568	reliability of the exam, strong relationship between what
4 198436	0.70	1	0.664	0.560	0.265	568	
5 198441	-0.60	4	0.826	0.495	0.188	568	item is measuring and overall test
6 198442	0.23	4	0.725	0.590	0.264	568	• Low + values = item not contributing to the overall
7 198446	-0.23	7	0.783	0.595	0.245	568	
8 198447	-1.90	1	0.933	0.326	0.081	568	reliability of the exam, little to no relationship between
9 198449	0.32	7	0.713	0.561	0.254	568	item and overall test
10 198450	0.09	4	0.743	0.636	0.278	568	
11 198451	0.05	4	0.748	0.572	0.249	568	• - values = item is reducing overall exam reliability,
12 198452	-1.53	1	0.910	0.264	0.076	568	inverse relationship between what item is measuring and
13 198453	-0.45	4	0.810	0.484	0.190	568	
14 198455	0.58	4	0.680	0.648	0.302	568	overall test
15 198456	-0.29	7	0.790	0.462	0.188	568 568	• Other factors being agreed items with higher reliability
16 198458	0.26	1	0.722	0.387	0.174	568	• Other factors being equal, items with higher reliability
17 198459	-2.81	4	0.970	0.268	0.046	568	values will be selected first for forms
18 198460	-0.38	1	0.801	0.571	0.228	568	
19 198463	-0.50	7	0.815	0.491	0.191	568	5 0.054 17.0 Keep
20 198464	1 47	1	0.562	0.720	0.357	568	8 0.054 36.0 Keen
▶ ► Paramete	ers Item S	ele	ection /	Option Analysis	Form	Level An	alysis / Rasch Item File / Rasch Person File / Person Item Map / Moving Avg Gra



Item-Level Statistics: Response Time





Item-Level Statistics: Identification of Poorly Performing Items

Item Selection Spreadsheet



Item Flagging

- Items with issues based on their statistical performance
- Default parameters can be set depending on exam situation
- P-values
 - Items with p-values > 0.90 = "too easy"
 - Items with p-values < 0.10 = "too hard"
- Item score correlation
 - Items with correlation < critical correlation = "no"
 - Items with correlation < critical correlation = "neg"
- Option analysis
 - Letter of incorrect response with higher correlation, p-value, or high scoring candidates than correct option





Keep

Item-Level Statistics: Option Analysis

- Provides breakdown of how well each response is performing as a correct (key) or incorrect (distractor) answer
 - P-value: Distractors with p-values higher than the key
 - <u>Item-Score Correlation</u>: Distractors with high positive correlations or correlations higher than the key
 - Frequency count: Distractors with frequent selection by high performing examinees

option	p-value	correlation avg. time		28 to 60	61 to 76	77 to 110	111 to 116	117 to 120
Α	0.007	-0.061	69	3			1	
> B	0.445	0.620	45	12	12	52	83	94
C	0.025	-0.163	97	10	2	1	1	
D	0.523	-0.556	58	92	97	63	36	9



Provides the overall test statistics by form

Health Check	Form A
Candidate Count	568
Exam Length	120
Mean	88.93
SD	27.65
Median	99.5
Mode	118 🔪
Avg. Time on Test	66.2
SD of Time on Test	27.6
Standard Error of the Mean	1.16
95% confidence interval +/-	2.27
Minimum	28
Maximum	120
Skewness	-0.38 📉
Kurtosis	-1.36
Alpha Reliability	0.981
SEM	3.84
95% confidence interval +/-	7.53
# Items in Test Pool	120

Mean: Average exam score of all examinees, difficulty of exam for candidates

<u>Standard deviation</u>: Variability in exam scores; higher values indicate scores vary greatly from the mean while lower values indicate scores are more closely clustered about the mean

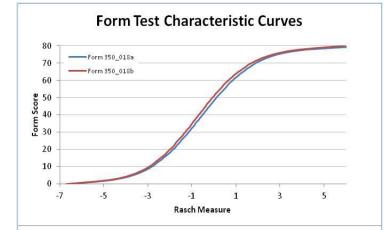
Total Test Time: Median amount of time candidates took on the entire exam; exams with short average time and high performance should be reviewed

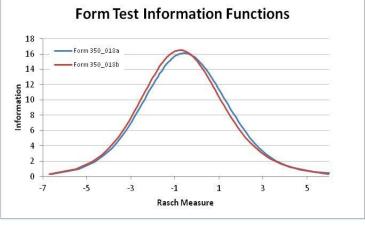
Reliability: Consistency of items as an entire exam, how well the items as a test seem to be measuring the same knowledge, should be > 0.85 for certification exams



- Form-level analysis shows test-level statistics by form
 - Metrics such as average difficulty, time, and pass rates
 - Imbalanced statistics and differing item difficulties along the ability continuum indicate current misalignment

Health Check	Form A	Form B
Exam Length	80	80
Mean	72.00	72.29
SD	10.25	10.84
Rasch Measure at Cut Score	1.90	1.70
Avg. Time on Test	35.4	37.3
Standard Error of the Mean	0.46	0.44
95% confidence interval +/-	0.90	0.85
Minimum	11	14
Maximum	80	80
Alpha Reliability	0.953	0.959
SEM	2.23	2.19
95% confidence interval +/-	4.38	4.29
Pass Rate	80.2%	81.4%

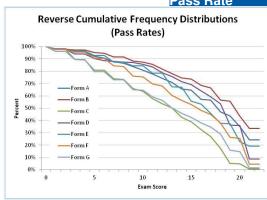


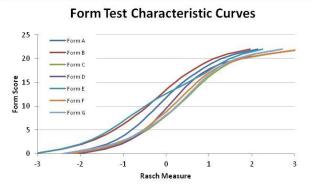


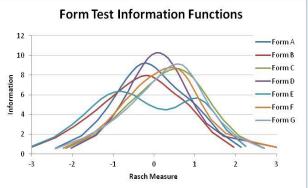


- Differences in difficulty indicative of non-equivalent exam forms
 - Need to have overlapping content to enable either pre- or post-equating of the forms to ensure fair scoring

Health Check	Form A	Form B	Form C	Form D	Form E	Form F	Form G
Candidate Count	321	223	275	231	249	495	313
Exam Length	10	10	10	10	10	10	10
Mean	15.51	16.90	11.44	15.56	15.00	13.87	11.96
SD	6.16	5.73	5.76	5.80	5.79	5.89	6.36
Rasch Measure at Cut Score	0.69	0.51	1.11	0.84	0.91	0.99	1.05
Standard Error of the Mean	0.34	0.38	0.35	0.38	0.37	0.26	0.36
95% confidence interval +/-	0.67	0.75	0.68	0.75	0.72	0.52	0.70
Alpha Reliability	0.831	0.828	0.757	0.813	0.814	0.788	0.811
SEM	2.53	2.38	2.84	2.50	2.50	2.71	2.76
95% confidence interval +/-	4.96	4.66	5.57	4.91	4.90	5.31	5.41
Pass Rate	56.7%	66.4%	26.9%	59.3%	45.8%	45.1%	34.8%

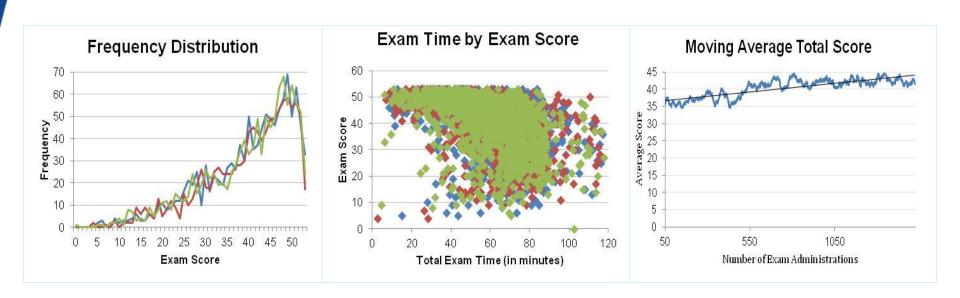








▲ Can provide evidence of exam security or potential compromise





Publish Parallel and Balanced Forms Through

FORMS ASSEMBLY & EQUATING



Stage in Process





Purpose

- ▲ Determine specifications for live exam including number of test forms, items and/or points per form, and administration time
- Assemble one or more parallel operational forms
 - Parallel test forms should have equivalent statistical characteristics and proper blueprint representation
- ▲ Provide fair, equated scores resulting in similar score interpretation for all candidates regardless of test form taken



Exam Release Cycle

- Alpha test complex item types (optional)
- Administer beta forms to gather initial itemlevel statistics and exam-level data
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Beta Item
Selection

Forms Assembly

- Review exam and formlevel statistics
- Delete items that are not performing well
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- Keep items that are performing well as viable for new forms
- Conduct standard setting

- Administer operational forms
- Provide pass/fail decisions to beta candidates
- Seed unscored items to pilot and obtain statistics
- After reaching a certain administration period or candidate volume, send data to Alpine for analysis

Health Check



Form Assembly Process

Review item and form statistics & make keep/delete decisions Make decisions about other necessary inputs for forms assembly

Assemble equated and balanced forms

Review item lists, equated cut score, and form specifications Provide delivery vendor with form item lists and effective cut score



Forms Assembly Considerations

- ▲ Equate to the raw cut score to ensure fair scoring and equivalent score interpretation across versions
- ▲ Balance content, item and form difficulty, reliability, variance and test time across forms
- ▲ Scale to the scaled cut score to increase interpretability and meaning of candidates' raw scores
- ▲ Maximize content relevancy and item quality by replacing older items with previously unscored items
- ▲ Minimize item exposure by keeping item overlap low and retiring items with known performance issues



Equating & Scaling

 Expectations for the ability-level needed to achieve a particular performance level remains consistent, fair, and known regardless of exam version/form

Cut Score Selection (Raw & Scaled) following standard setting process

Administer
Operational
Forms &
deliver results

Item & Form-Level Analysis - Current Raw | Rasch Relationship Rasch|Scale
Score Link
Applied to
effective cut on
newly
proposed
Forms

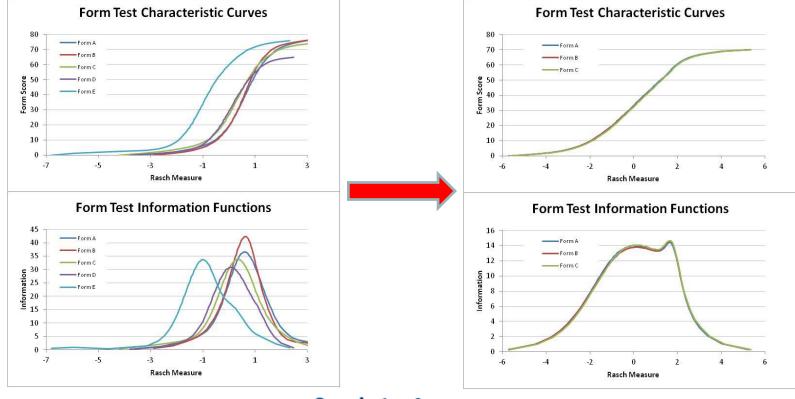
Receive & review new forms lists from forms assembly

Provide delivery vendor with new item lists, effective cut score, & scale score table



Equating

 Differences in difficulty across forms can be accommodated for through either pre- or postequating, resulting in aligned scoring decisions





Scaling

- Eases the interpretability of exam scores and pass/fail decisions
- Important to the valid interpretation of exam scores as it assigns meaningful links between raw scores, underlying ability measures, and scale scores
- ▲ Ensures consistency of the scale score meaning regardless of which administration/version/form of an exam a candidate receives



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QUESTIONS?

